## RSITY OF CALIFORNIA, SANTA BARBARA

DRC 2023	UNIVERS
<b>SUNDAY</b> - 6/25	
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Breaks will	University
take place in Lagoon Plaza	Crystal grow new 2D o Zde 1
Poster Session	fMAX Exceeding Oxide Thin-Film To Gat 1
will take place in Lagoon Plaza	Local Back-Gate Mo Channel Lengths Do Showing Improved Jaikisso
iii Lagooii i iaza	High-Perfor with Bi/Sb Co 2
	High performance through defect e
	Session
	A mobility stud low-κ/hig 3:
	Up to 100-fold I Voltage Stability
UNIVERSITY CENTER, SANTA BARBARA HARBOR	Hysteresis and the exotic Bi2SeO5 and
Short Course: Two-Dimensional Materials for the Semiconductor Industry 1:00-5:00 pm	Drift of Schottky Ba Materi
UNIVERSITY CENTER, LAGOON PLAZA	Ultra Steep Slope ( Bilayer 4
Welcome Reception 6:00-8:00 pm	

DAY - 6/25	Intro and Awards 9:00-9:20 am, University Center, Corwin West		
	Plenary: EPI (Electronic Photon Kei May Lau, The Hong Kong Universit 9:20-10:20 am, Universit	ry of Science and Technology (invited)	
	COFFEE BREAK	10:20-10:40 AM	
	25 Years of Development—From Esto Wide Adoption in Atom Gerhard Klimeck, Purd 10:40-11:40 am, Univers	mistic Device Simulation ue University (invited)	
ee	LUNCH 11:40 am-1:00 pm (Not provided by Conference)		
will	Session 1: 2D Electronics I University Center, Corwin East	Session 2: WBG I: Electronics University Center, Corwin West	
ice in	Crystal growth and applications of new 2D dielectric materials  Zdenek (invited),  1:00-1:40 pm	Multi-Channel β-Ga2O3/(Al0.2Ga0.8)2O3 MODFETs, Dheenan 1:00-1:20 pm	
Plaza		First GaN/AIN p-channel FinHFETs on Single-Crystal AIN Substrates, Zhang 1:20-1:40 pm	
Session	fMAX Exceeding 3 GHz in Self-Aligned Zinc- Oxide Thin-Film Transistors with Micron-Scale Gate Length, Ma 1:40-2:00 pm	Large-scale vertically stacked ultrawide bandgap oxides for CMOS IC, Yuvaraja 1:40-2:00 pm	
e place on Plaza	Local Back-Gate Monolayer MoS2 Transistors with Channel Lengths Down to 50 nm and EOT ~ 1 nm Showing Improved Ion using Post-Metal Anneal, Jaikissoon, 2:00-2:20 pm	β-Ga2O3 FinFETs by MacEtch: temperature dependent I-V characteristics, Ren 2:00-2:20 pm	
Joil Fluzu	High-Performance WS <sub>2</sub> MOSFETs with Bi/Sb Composite Contacts, Wen 2:20-2:40 pm  High performance monolayer WSe2 devices through defect engineering and doping, Tan	Complex oxide membranes as dielectrics for 2D electronics, Jalan (invited) 2:20-3:00 pm	
	2:40-3:00 pm		
	COFFEE BREAK		
	Session 3: 2D Electronics II  A mobility study of monolayer MoS2 on low-κ/high-κ dielectrics, Sun	Session 4: WBG II: Power  Gallium oxides devices for GW/MV transmission	
	3:20-3:40 pm  Up to 100-fold Improvement of Threshold Voltage Stability in ITO Transistors, Wahid 3:40-4:00 pm	and high power switched mode RF amplifiers Singsetti (invited) 3:20-4:00 pm	
, SANTA BARBARA HARBOR	Hysteresis and thermal stability in FETs with exotic Bi2SeO5 and MnAl2S4 insulators, Illarionov 4:00-4:20 pm	GaN-on-GaN PN Power Diode with a Breakdov Voltage of 7.86 kV, Xu 4:00-4:20 pm	
-Dimensional Materials conductor Industry 0-5:00 pm	Drift of Schottky Barrier Height in Phase Change Materials, Nir-Harwood 4:20-4:40 pm	GaN Super-Heterojunction Powe Switches for Improved Voltage Handling and	
NTER, LAGOON PLAZA	Ultra Steep Slope Cryogenic MOSFETs Based on Bilayer Graphene, Icking 4:40-5:00 pm	Radiation Hardness, Chu (invited)  4:20-5:00 pm	
ne Reception 0-8:00 pm		First Demonstration of 15A/1.4 kV Large Area Trench β-Ga2O3 Schottky Barrier Diode with High-k RESURF, Roy 5:00-5:20 pm	
	POSTER SESSION 6:00-9:00 PM		
	0.00-9.		

Plenary: Integrated Printed and Flexible Electronic Systems, Ana Claudia Arias, University of California, Berkeley (invited) 9:00-10:00 am, University Center, Corwin West			
COFFEE BREAK	10:00-10:20 AM		
Session 5: Flexible Electronics University Center, Corwin East	Session 6: WBG III: RF Device University Center, Corwin West		
Carbon-based nanomaterial inks for print-in-place, recyclable, and water-based electronics, Franklin (invited) 10:20-11:00 am	AlN/GaN HEMT with 14.1 W/mm Output Power Density at 10 GHz, Cheng 10:20-10:40 am		
	Temperature dependent properties of high-speed 15-GHz epitaxial AIN FBARs, Zhao 10:40-11:00 am		
Flexible CMOS electronics based on 2D p-type WSe2 and n-type MoS2, Piacentini 11:00-11:20 am	First Demonstration of GaN RF HEMTs on Engineered Substrate, Yadav 11:00-11:20 am		
Quantum transport simulations for the next decade: Exploiting quantum topology in	Fully Epitaxial, Reconfigurable Ferroelectric ScAlN/AlGaN/GaN HEMTs, Wang 11:20-11:40 am		
emerging 2D-devices, Muralidharan (invited) 11:20-12:00 pm	<i>Late News</i> 11:40-12:00 pm		
Fully Integrated Flexible RF Detectors in MoS2 and Graphene based MMIC, Palacios 12:00-12:20 pm	<i>Late News</i> 12:00-12:20 pm		
LUNCH 12:20-1:20 pm (Not provided by Conference)			
Session 7: Emerging Devices I	Session 8: WBG IV: HEMT		
Josephson parametric amplifiers for rapid, high-fidelity measurement of solid-state qubits, Shankar (invited)  1:20-2:00 pm	W-band fully passivated AlN/GaN HEMT device with 56% power-added efficiency and 780 mW/mm output power density at 94 GHz, Arkun 1:20-1:40 pm		
	AIN/AI0.25Ga0.75N/AIN Quantum Well HEMTs with fT/fmax of 67/166 GHz, Kim 1:40-2:00 pm		
The D4-TFT: A Point-of-Care Carbon Nanotube BioFET for Ultrasensitive Detection of Biomarkers, Albarghouthi 2:00-2:20 pm	90 nm GaN Technology for Millimeter-Wave Power Applications to W-Band and Beyond, Srivastava 2:00-2:20 pm		
Ultra-compact ternary content-addressable memory cell based on single ambipolar two-dimensional floating-gate transistor, Cai 2:20-2:40 pm	Recent Advances in GaN HEMT Modeling using Fermi Kinetics Transport Miller (invited) 2:20-3:00 pm		
Multifunctional Resistance Switching in Monolayer Hexagonal Boron Nitride Atomristor, Yang 2:40-3:00 pm			
COFFEE BREAK	3:00-3:20 PM		
Session 9: Emerging Devices II	Session 10: Optoelectronics		
Graded AlGaN/GaN heterojunction bipolar transistors with 101 kA/cm2 collector current density using patterned area regrown base contacts, Joishi 3:20-3:40 pm	Size dependent characteristics of AlGaN-based ultraviolet micro-LEDs, Yao 3:20-3:40 pm		
GaN/AIN Resonant Tunneling Field Effect Transistors, Encomendero 3:40-4:00 pm	Lattice-Matched InAsSbBi Photodetectors for Long-Wave Infrared Sensing, White 3:40-4:00 pm		
Heterogenous integration of 3D vertically stacked metal-oxide transistors, Yuvaraja 4:00-4:20 pm	Enhanced injection efficiency in double-color III-Nitride LEDs, Chlipala 4:00-4:20 pm		
<i>LATE NEWS</i> 4:20-5:00 pm	<b>LATE NEWS</b> 4:20-5:00 pm		
Conference Dinner Reception Goleta Beach (6:00 pm - 7:45 pm)			
Rump Session - University Center, Corwin West			

What makes a good device paper and how do you measure its impact? Panelists: Aaron Franklin, Duke University; Azad Naeemi, Georgia Institute of Technology;

Becky (R.L.) Peterson, University of Michigan; Curt Richter, National Institute of Standards

and Technology; Mark Rodwell, University of California, Santa Barbara

8:30-10:30 pm

**TUESDAY** - 6/27

## WEDNESDAY - 6/28 **EMC Awards Ceremony & Plenary Session** Suboxide Molecular-Beam Epitaxy, Darrell Schlom, Cornell University (invited) 8:20-9:20 am, Music Building, Lotte Lehmann COFFEE BREAK 9:20-10:00 AM **Session 11: Memory** University Center, Corwin West FeFET-Based Synaptic Cross-Bar Arrays for Deep Neural Networks: Impact of Ferroelectric Thickness on Device-Circuit Non-Idealities and System Accuracy, Wang, 10:00-10:20 am **Origin of Polarization Charges Probed in Bulk** Si:HfO2 FeFET, Dahan 10:20-10:40 am Solving optimization tasks power-efficiently exploiting VO2's phase-change properties with Oscillating Neural Networks, Maher 10:40-11:00 am **Domain Wall Magnetic Tunnel Junction Artificial Neuron with Tunable Stochasticity for Computing** on the Edge, Leonard 11:00-11:20 am **Computational Associative Memory Powered by** Ferroelectric Memory, Ni (invited) 11:20-12:00 pm **LUNCH** 12:00-1:00 pm (Not provided by Conference) **Session 12: Devices for Extreme Conditions** Radiation Effects in AlGaN/GaN HEMTs and Gallium Oxide Diodes, Fleetwood (invited) 1:00-1:40 pm Single-Event Burnout by Cf-252 Irradiation in Vertical β-Ga2O3 Diodes with Pt and PtOx Schottky **Contacts and High Permittivity Dielectric Field Plate,** Islam, 1:40-2:00 pm **Technology scaling effects on SRAM-PUF** reliability under ionizing radiation, Surendranathan 2:00-2:20 pm Fast switching (<10 ns) characteristics and long stress (190 h) operation of NO2-doped p-channel diamond MOSFETs, Saha 2:20-2:40 pm

DRC PARTICIPANTS CAN ATTEND BOTH DRC AND EMC SESSIONS ON WEDNESDAY